

Portable device

According to §15.247(e)(i) and §1.1307(b)(1), systems operating under the provisions of this section shall be operated in a manner that ensures that the public is not exposed to radio frequency energy level in excess of the Commission's guidelines.

According to KDB447498 D01 General RF Exposure Guidance V05

The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

$[(\text{max. power of channel, including tune-up tolerance, mW})/(\text{min. test separation distance, mm})] * [\sqrt{f(\text{GHz})}] \leq 3.0$ for 1-g SAR and ≤ 7.5 for 10-g extremity SAR, where

$f(\text{GHz})$ is the RF channel transmit frequency in GHz;

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Power and distance are rounded to the nearest mW and mm before calculation;

The result is rounded to one decimal place for comparison;

The test exclusions are applicable only when the minimum test separation distance is ≤ 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion.

We use 5mm as separation distance to calculate.

Maximum measured transmitter power:

BT DSS:

Transmit Frequency (GHz)	Mode	Measured Power (dBm)	Tune-up power (dBm)	Max tune-up power(dBm)	Result calculation	1-g SAR
2.402	GFSK	5.43	6 \pm 1	7	2.1698	3
2.441	GFSK	6.72	6 \pm 1	7	2.1873	3
2.480	GFSK	6.55	6 \pm 1	7	2.2047	3
2.402	π /4-DQPSK	5.38	6 \pm 1	7	2.1698	3
2.441	π /4-DQPSK	5.48	6 \pm 1	7	2.1873	3
2.480	π /4-DQPSK	5.37	6 \pm 1	7	2.2047	3
2.402	8DPSK	5.69	6 \pm 1	7	2.1698	3
2.441	8DPSK	5.90	6 \pm 1	7	2.1873	3
2.480	8DPSK	5.77	6 \pm 1	7	2.2047	3

BT DTS:

2.402	GFSK	6.58	7 \pm 1	8	2.4797	3
2.440	GFSK	7.15	7 \pm 1	8	2.4993	3
2.48	GFSK	6.92	7 \pm 1	8	2.5197	3

Conclusion:

For the max result : $2.5197 \leq 3.0$ for 1-g SAR extremity SAR, No SAR is required.

Jason chen

Signature:

Date: 2016-8-12

NAME AND TITLE (Please print or type): Brown Lu/Manager

COMPANY (Please print or type): Shenzhen NTEK Testing Technology Co., Ltd./ 1/F, Building E, Fenda Science Park, Sanwei Community, Xixiang Street Bao'an District, Shenzhen P.R. China.